



Product data sheet

1. General description

Ultrafast power diode (Bare die without sawn).

2. Features and benefits

- Fast reverse recovery
- Low leakage current
- Low forward voltage drop
- Bare die

3. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
V_{RRM}	repetitive peak reverse voltage		[1]	600		V	
I _{F(AV)}	average forward current	δ = 0.5; square-wave pulse	[2]	15		А	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
V _F	forward voltage	I _F = 5 A; T _j = 25 °C	[2]	1.07	1.20	1.36	V
Dynamic	characteristics						
Q _r	recovered charge	I_F = 1 A; V_R = 20 V; dI_F/dt = 20 A/µs; T_j = 25 °C	[2]	-	-	50	nC
t _{rr}	reverse recovery time	I _F = 1 A; V _R = 30 V; dI _F /dt = 100 A/µs; T _i = 25 °C	[2]	-	30	-	ns

4. Ordering information

Table 2. Ordering information

Product type	Orderable part number	Description	Packing method
WB15FV60AL	WB15FV60ALZ	Bare die on wafer	Unsawn wafer, Vacuum packing

5. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{RRM}	repetitive peak reverse voltage		[1]	600	V
V_{RWM}	crest working reverse voltage		[1]	600	V
V _R	reverse voltage	DC	[1]	600	V
I _{F(AV)}	average forward current	δ = 0.5; square-wave pulse	[2]	15	А
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 µs; square-wave pulse	[2]	30	А
I _{FSM} non-repet current	non-repetitive peak forward	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	[2]	160	А
	current	t_p = 8.3 ms; $T_{j(init)}$ = 25 °C;sine-wave pulse	[2]	175	А
Tj	junction temperature			-40 to 175	°C

6. Characteristics

Table 4. Cl	naracteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static characteristics							
V _F	forward voltage	I _F = 5 A; T _j = 25 °C	[2]	1.07	1.20	1.36	V
		I _F = 15 A; T _j = 25 °C	[2]	-	1.40	1.80	V
		I _F = 15 A; T _j = 150 °C	[2]	-	1.00	1.40	V
I _R	reverse current	V _R = 600 V; T _j = 25 °C	[1]	-	-	10	μA
		V _R = 600 V; T _j = 150 °C	[2]	-	-	1	mA
Dynamic	characteristics			,			
Q _r	recovered charge	$I_F = 1 \text{ A}; V_R = 20 \text{ V}; \text{ d}I_F/\text{d}t = 20 \text{ A}/\mu\text{s};$ $T_j = 25 ^\circ\text{C}$	[2]	-	-	50	nC
t _{rr}	reverse recovery time	$I_{\text{F}} = 1 \text{ A}; V_{\text{R}} = 30 \text{V}; \text{d} I_{\text{F}}/\text{d} t = 100 \text{A}/\mu\text{s}; \\ T_{\text{j}} = 25 ^{\circ}\text{C}$	[2]	-	30	-	ns

Notes:

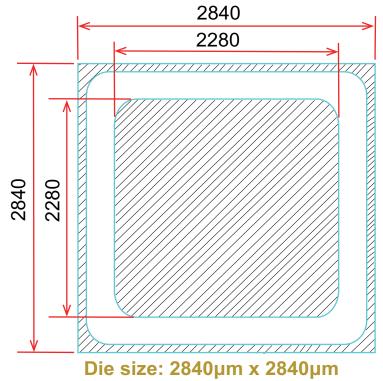
[1] means that parameter are 100% test at T_{amb} = 25°C. [2] means that the guaranteed ratings and parameter limits will depend on the assembled structure. When correctly assembled with suitable die bonding and wire bonding, the device will have ratings and characteristics guaranteed in this data sheet, similar to the assembled devices.

WB15FV60AL

Ultrafast power diode - Bare die

MECHANICAL PARAMETER		
Chip size	2.84 x 2.84	mm ²
Anode pad size	2.28 x 2.28	mm ²
Area total / active	8.07 / 5.20	mm ²
Thickness	300	μm
Wafer size	125	mm
Max possible chips per wafer	1371	pcs
Passivation	Glass	
Front metal	Al	
Back metal	Ti Ni Ag	

CHIP LAYOUT



Bond pad size: 2280µm x 2280µm

WB15FV60AL

Ultrafast power diode - Bare die

7. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
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